

AO4496





General Description

The AO4496/L uses advanced trench technology to provide excellent $R_{DS(ON)}$ with low gate charge. This device is suitable for use as a DC-DC converter application. AO4496 and AO4496L are electrically identical.

-RoHS Compliant -AO4496L is Halogen Free

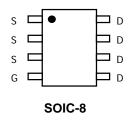
Features

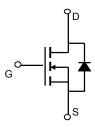
 $V_{DS}(V) = 30V$

$$\begin{split} I_D &= 10 A & (V_{GS} = 10 V) \\ R_{DS(ON)} &< 19.5 m \Omega & (V_{GS} = 10 V) \\ R_{DS(ON)} &< 26 m \Omega & (V_{GS} = 4.5 V) \end{split}$$

UIS TESTED!

Rg, Ciss, Coss, Crss Tested





Absolute Maximum Ratings T _J =25°C unless otherwise noted							
Parameter		Symbol	Maximum	Units			
Drain-Source Voltage		V_{DS}	30	V			
Gate-Source Voltage		V_{GS}	±20	V			
Continuous Drain	T _A =25°C		10				
Current ^A	T _A =70°C	I _D	7.5	A			
Pulsed Drain Current ^B		I _{DM}	50				
Avalanche Current ^G		I _{AR}	17				
Repetitive avalanche energy L=0.1mH ^G		E _{AR}	14	mJ			
Power Dissipation ^A	T _A =25°C	Р	3.1	W			
	T _A =70°C	$-P_{D}$	2.0	\ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \			
Junction and Storage Temperature Range		T _J , T _{STG}	-55 to 150	°C			

Thermal Characteristics								
Parameter	Symbol	Тур	Max	Units				
Maximum Junction-to-Ambient A	t ≤ 10s R _{θJA}		31	40	°C/W			
Maximum Junction-to-Ambient A	Steady State	κ_{θ} JA	59	75	°C/W			
Maximum Junction-to-Lead ^C	Steady State	$R_{ hetaJL}$	16	24	°C/W			

Electrical Characteristics (T_{.j}=25°C unless otherwise noted)

Symbol	Parameter	Conditions	Min	Тур	Max	Units
STATIC P	PARAMETERS					
BV _{DSS}	Drain-Source Breakdown Voltage	$I_D = 250 \mu A, V_{GS} = 0 V$	30			V
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} = 30V, V _{GS} = 0V			1	μА
		T _J = 55°C		5		
I_{GSS}	Gate-Body leakage current	$V_{DS} = 0V$, $V_{GS} = \pm 20V$			±100	nA
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS} = V_{GS} I_D = 250 \mu A$	1.4	1.8	2.5	V
$I_{D(ON)}$	On state drain current	$V_{GS} = 10V, V_{DS} = 5V$	50			Α
R _{DS(ON)}	Static Drain-Source On-Resistance	V _{GS} = 10V, I _D = 10A		16	19.5	
		T _J =125°C		24	29	mΩ
		$V_{GS} = 4.5V, I_D = 7.5A$		21	26	
g FS	Forward Transconductance	$V_{DS} = 5V, I_{D} = 10A$		30		S
V_{SD}	Diode Forward Voltage	$I_S = 1A, V_{GS} = 0V$		0.76	1	V
I _S	Maximum Body-Diode Continuous Current				3	Α
DYNAMIC	PARAMETERS					
C _{iss}	Input Capacitance			550	715	pF
Coss	Output Capacitance	V_{GS} =0V, V_{DS} =15V, f=1MHz		110		pF
C_{rss}	Reverse Transfer Capacitance			55		pF
R_g	Gate resistance	V _{GS} =0V, V _{DS} =0V, f=1MHz	3	4	5.5	Ω
SWITCHI	NG PARAMETERS					
Q _g (10V)	Total Gate Charge			9.8	13	nC
Q _g (4.5V)	Total Gate Charge	\ -10\\ \\ =15\\ =10\		4.6	6.1	nC
Q_{gs}	Gate Source Charge	V_{GS} =10V, V_{DS} =15V, I_{D} =10A		1.8		nC
Q_{gd}	Gate Drain Charge	1		2.2		nC
t _{D(on)}	Turn-On DelayTime			5		ns
t _r	Turn-On Rise Time	V_{GS} =10V, V_{DS} =15V, R_{L} = 1.5 Ω ,		3.2		ns
t _{D(off)}	Turn-Off DelayTime	R_{GEN} =3 Ω		24		ns
t _f	Turn-Off Fall Time	1		6		ns
t _{rr}	Body Diode Reverse Recovery Time	I _F =10A, dI/dt=100A/μs		22	29	ns
Q _{rr}	Body Diode Reverse Recovery Charge	I _F =10A, dI/dt=100A/μs		14		nC

A: The value of R $_{\theta,JA}$ is measured with the device mounted on 1in² FR-4 board with 2oz. Copper, in a still air environment with T $_A$ = 25°C. The value in any given application depends on the user's specific board design.

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B: Repetitive rating, pulse width limited by junction temperature.

C. The R $_{\theta JA}$ is the sum of the thermal impedence from junction to lead R $_{\theta JL}$ and lead to ambient.

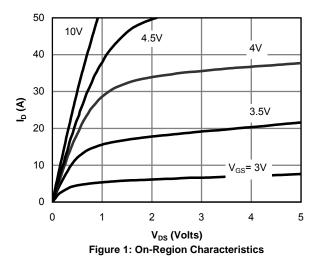
D. The static characteristics in Figures 1 to 6 are obtained using $t \leqslant 300 \mu s$ pulses, duty cycle 0.5% max.

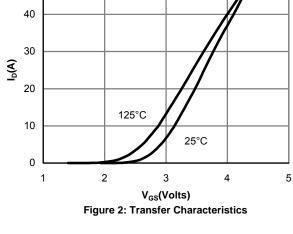
E. These tests are performed with the device mounted on 1 in 2 FR-4 board with 2oz. Copper, in a still air environment with T_A =25°C. The SOA curve provides a single pulse rating.

F. The current rating is based on the t \leq 10s thermal resistance rating.

G. $\rm E_{AR}$ and $\rm I_{AR}$ ratings are based on low frequency and duty cycles to keep $\rm T_{j}{=}25C.$

TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS





50

V_{DS}= 5V

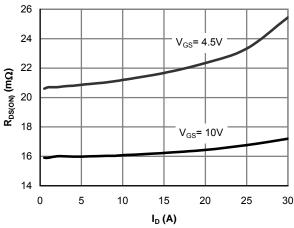


Figure 3: On-Resistance vs. Drain Current and Gate Voltage

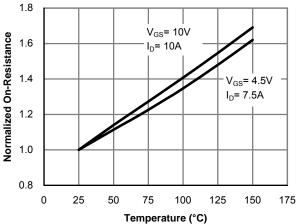


Figure 4: On-Resistance vs. Junction
Temperature

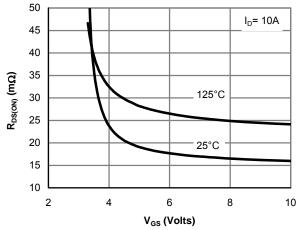


Figure 5: On-Resistance vs. Gate-Source Voltage

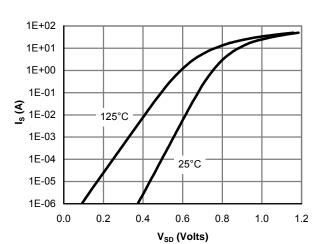


Figure 6: Body-Diode Characteristics

TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

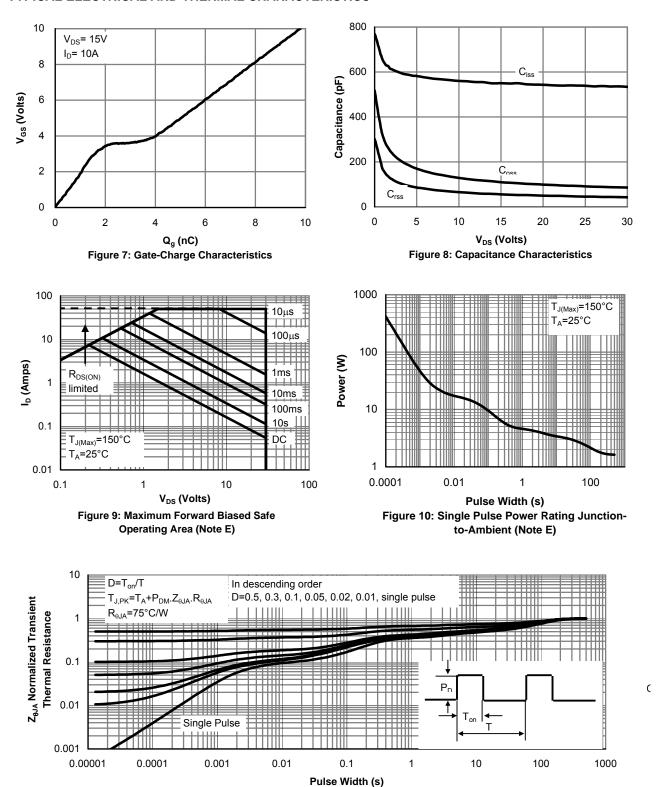
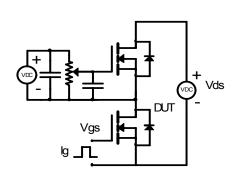
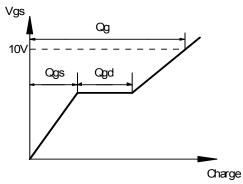


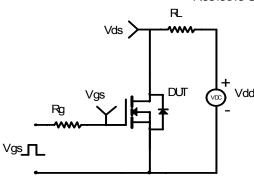
Figure 11: Normalized Maximum Transient Thermal Impedance(Note E)

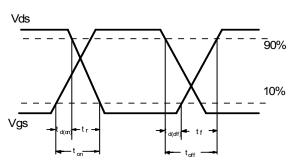
Gate Charge Test Circuit & Waveform



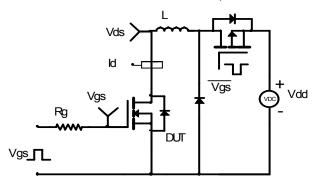


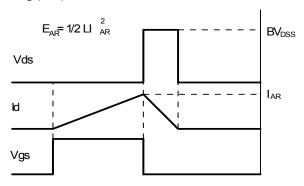
Resistive Switching Test Circuit & Waveforms





Unclamped Inductive Switching (UIS) Test Circuit & Waveforms





Diode Recovery Test Circuit & Waveforms

